

**Search Notes**

Application/Control No.

10/516,743

Examiner

Karen Cheng

Applicant(s)/Patent under  
Reexamination

OSADA ET AL.

Art Unit

1626

**SEARCHED**

Class	Subclass	Date	Examiner
548	453	11/17/2006	KC
549	548	11/17/2006	KC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN Structure Search (see attached)	11/14/2006	KC
Inventor Name Search	11/16/2006	KC
EAST Search (see attached)	11/17/2006	KC